

### General Description

- Latest advanced trench technology
- Low  $R_{DS(ON)}$
- High Current Capability
- RoHS and Halogen-Free Compliant

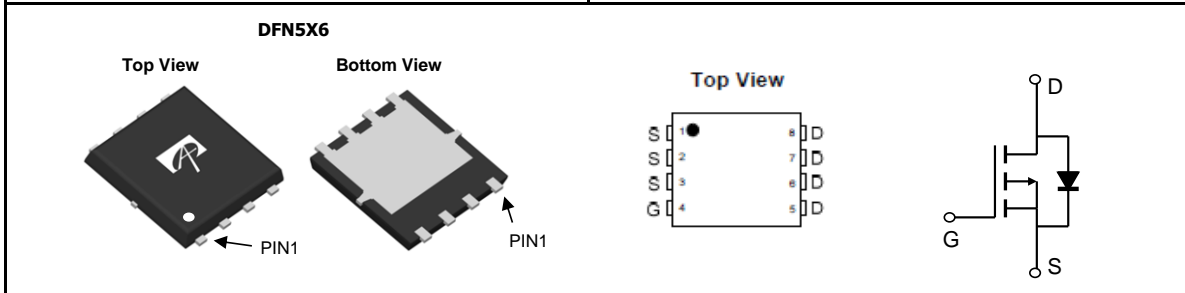
### Applications

- Notebook AC-in load switch
- Battery protection charge/discharge

### Product Summary

|                                   |                  |
|-----------------------------------|------------------|
| $V_{DS}$                          | -30V             |
| $I_D$ (at $V_{GS}=-10V$ )         | -36A             |
| $R_{DS(ON)}$ (at $V_{GS}=-10V$ )  | < 7.8m $\Omega$  |
| $R_{DS(ON)}$ (at $V_{GS}=-4.5V$ ) | < 12.3m $\Omega$ |

100% UIS Tested  
 100% Rg Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONS21357             | DFN 5x6      | Tape & Reel | 3000                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol         | Maximum                 | Units            |
|--|----------------|-------------------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$       | -30                     | V                |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 25$                | V                |
| Continuous Drain Current <sup>G</sup>          | $I_D$          | $T_C=25^\circ\text{C}$  | -36              |
|  |                | $T_C=100^\circ\text{C}$ | -36              |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$       | -144                    | A                |
| Continuous Drain Current                       | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | -21              |
|  |                | $T_A=70^\circ\text{C}$  | -17              |
| Avalanche Current <sup>C</sup>                 | $I_{AS}$       | 39                      | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}$       | 76                      | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$          | $T_C=25^\circ\text{C}$  | 48               |
|  |                | $T_C=100^\circ\text{C}$ | 19               |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 5.0              |
|  |                | $T_A=70^\circ\text{C}$  | 3.2              |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units                     |
|--|-----------------|-----|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 20  | 25  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 | 45  | 55  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 2.1 | 2.6 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter  | Conditions  | Min   | Typ  | Max       | Units         |
|-----------------------------|--|---|---|------|-----------|---------------|
| <b>STATIC PARAMETERS</b>    |  |   |   |      |           |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage                     | $I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$  | -30   |      |           | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current                    | $V_{DS}=-30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                   |   |      | -1<br>-5  | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-Body leakage current                          | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 25\text{V}$  |   |      | $\pm 100$ | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                             | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$  | -1.3  | -1.7 | -2.3      | V             |
| $R_{DS(on)}$                | Static Drain-Source On-Resistance                  | $V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$<br>$T_J=125^\circ\text{C}$                   |   | 6.3  | 7.8       | m $\Omega$    |
|                             |  | $V_{GS}=-4.5\text{V}$ , $I_D=-20\text{A}$   |   | 8.6  | 10.7      |               |
| $g_{FS}$                    | Forward Transconductance                           | $V_{DS}=-5\text{V}$ , $I_D=-20\text{A}$   |   | 50   |           | S             |
| $V_{SD}$                    | Diode Forward Voltage                              | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$   |   | -0.7 | -1        | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current <sup>G</sup> |   |   |      | -36       | A             |
| <b>DYNAMIC PARAMETERS</b>   |  |   |   |      |           |               |
| $C_{iss}$                   | Input Capacitance                                  | $V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$                           |   | 2830 |           | pF            |
| $C_{oss}$                   | Output Capacitance                                 |   |   | 430  |           | pF            |
| $C_{rss}$                   | Reverse Transfer Capacitance                       |   |   | 365  |           | pF            |
| $R_g$                       | Gate resistance                                    | $f=1\text{MHz}$   |   | 14   | 28        | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |  |   |   |      |           |               |
| $Q_g(10\text{V})$           | Total Gate Charge                                  | $V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-20\text{A}$                       |   | 50   | 70        | nC            |
| $Q_g(4.5\text{V})$          | Total Gate Charge                                  |   |   | 25   | 35        | nC            |
| $Q_{gs}$                    | Gate Source Charge                                 |   |   | 9    |           | nC            |
| $Q_{gd}$                    | Gate Drain Charge                                  |   |   | 12   |           | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                                  | $V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=0.75\Omega$ ,<br>$R_{GEN}=3\Omega$ |   | 12.5 |           | ns            |
| $t_r$                       | Turn-On Rise Time                                  |   |   | 18   |           | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                                 |   |   | 125  |           | ns            |
| $t_f$                       | Turn-Off Fall Time                                 |   |   | 66   |           | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time                   |   | $I_F=-20\text{A}$ , $di/dt=500\text{A}/\mu\text{s}$ |      | 62        |               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge                 | $I_F=-20\text{A}$ , $di/dt=500\text{A}/\mu\text{s}$                                   |   | 32   |           | nC            |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

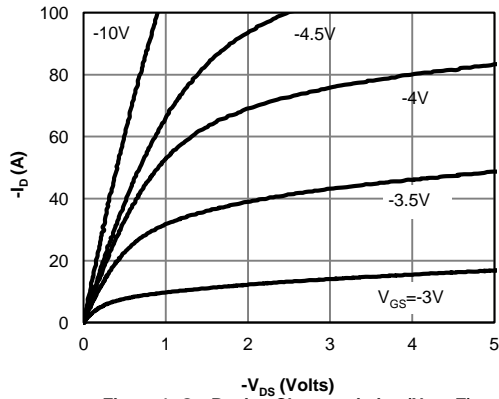


Figure 1: On-Region Characteristics (Note E)

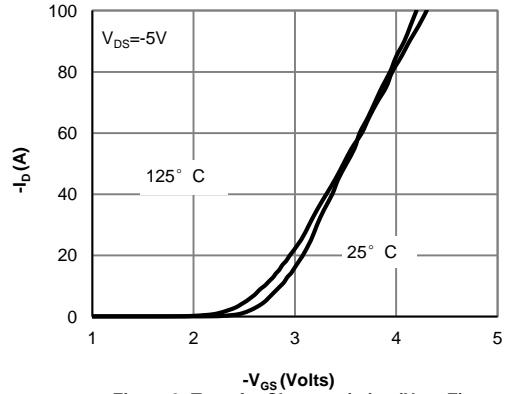


Figure 2: Transfer Characteristics (Note E)

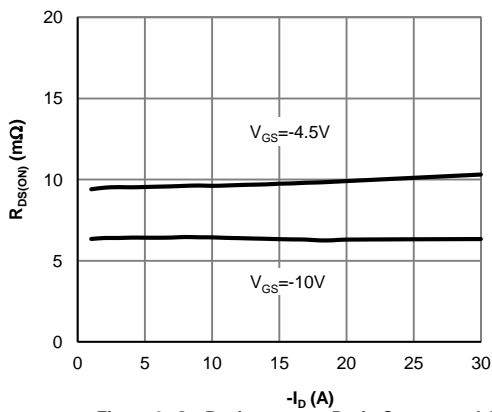


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

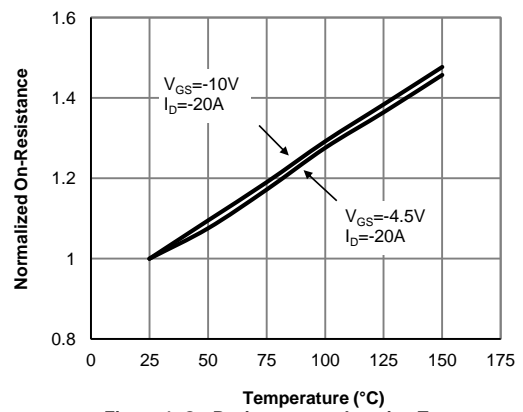


Figure 4: On-Resistance vs. Junction Temperature (Note E)

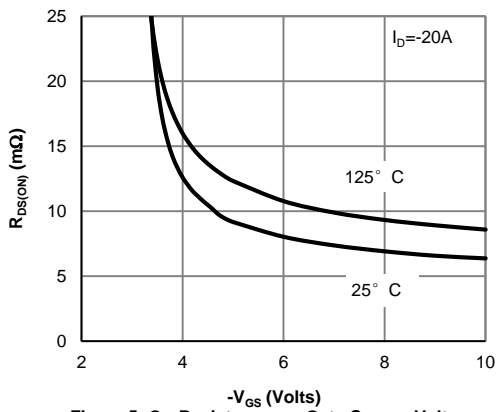


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

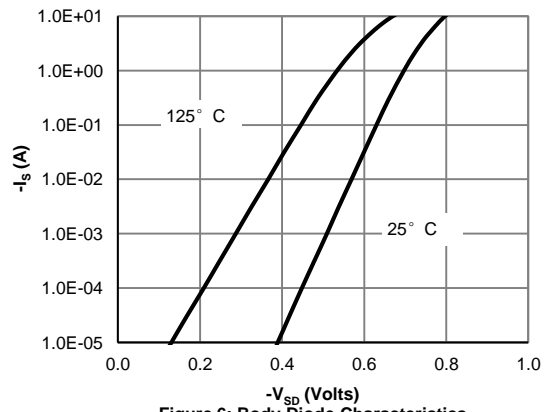


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

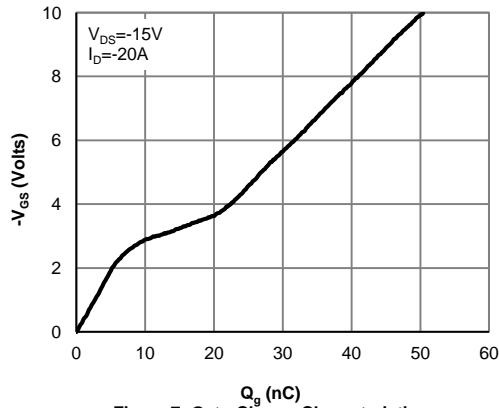


Figure 7: Gate-Charge Characteristics

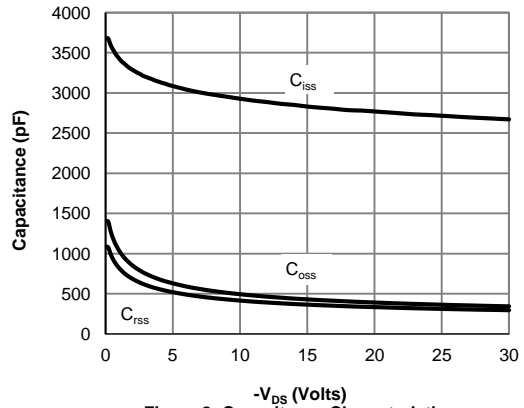


Figure 8: Capacitance Characteristics

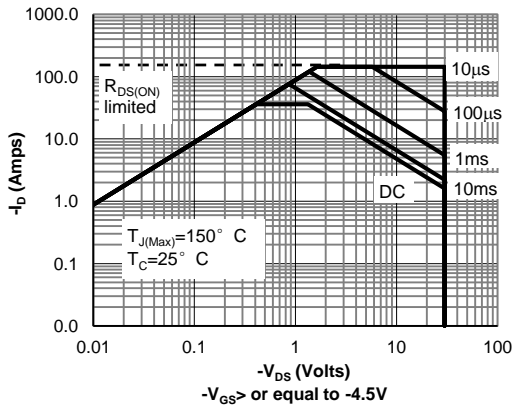


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

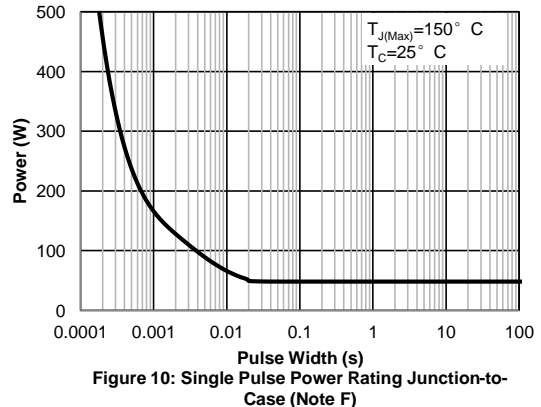


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

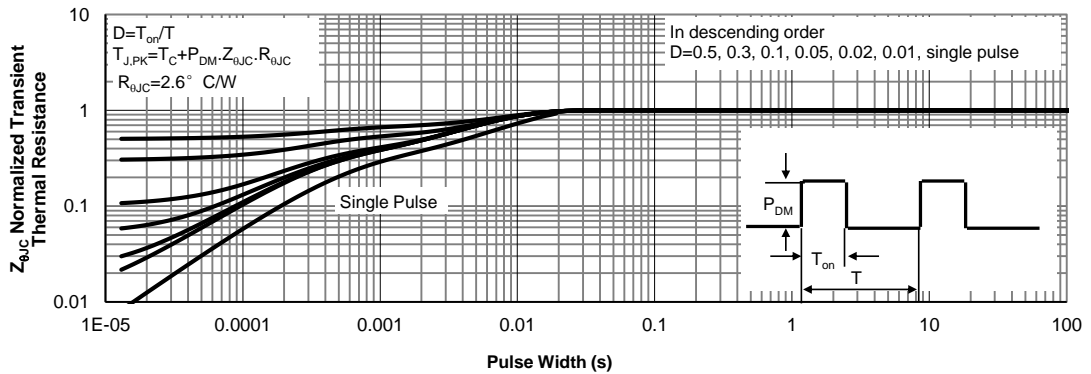


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

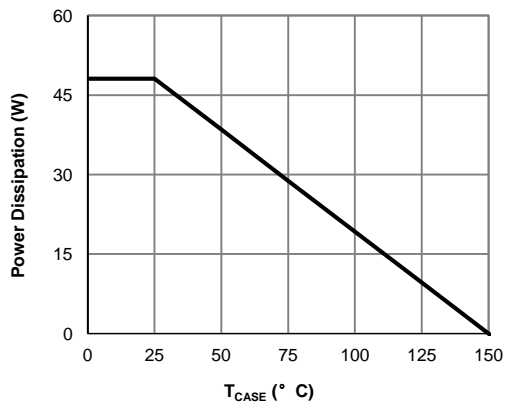


Figure 12: Power De-rating (Note F)

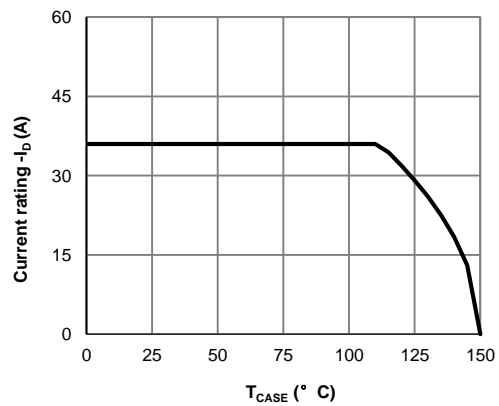


Figure 13: Current De-rating (Note F)

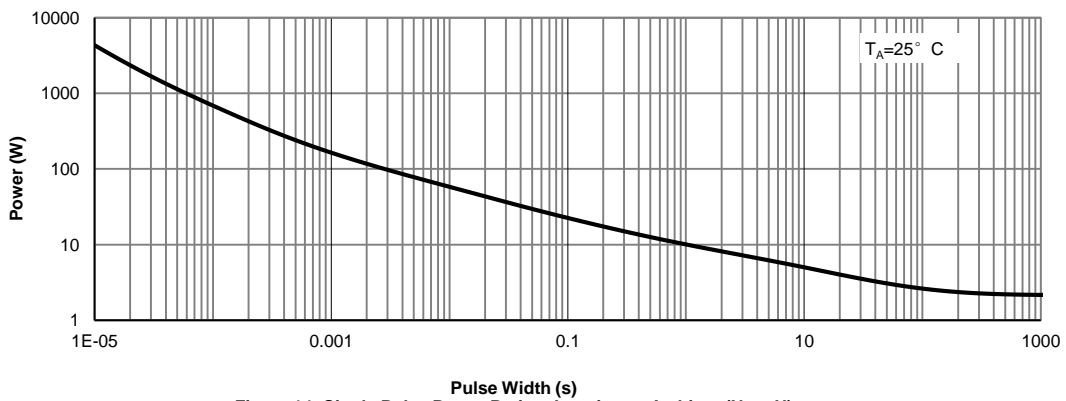


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

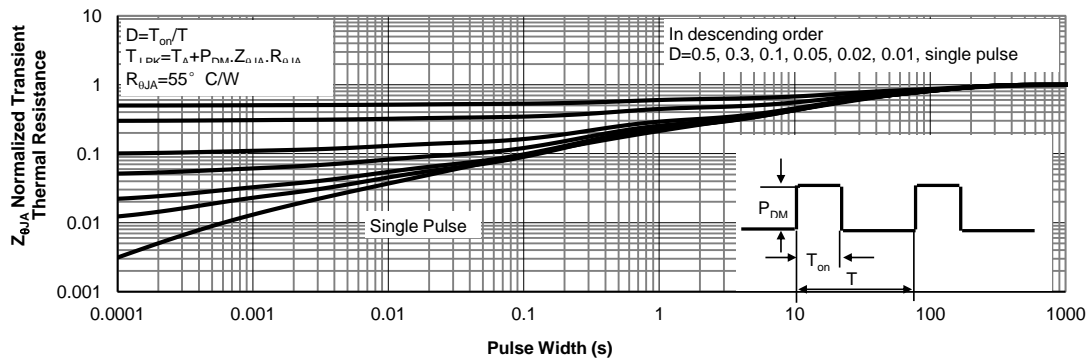
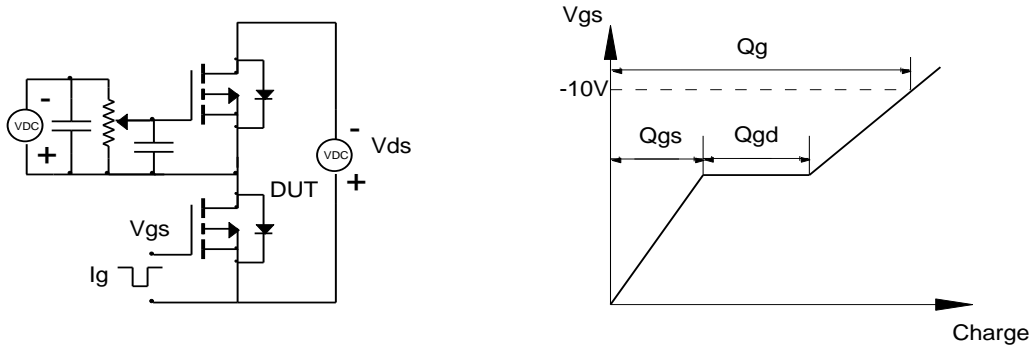
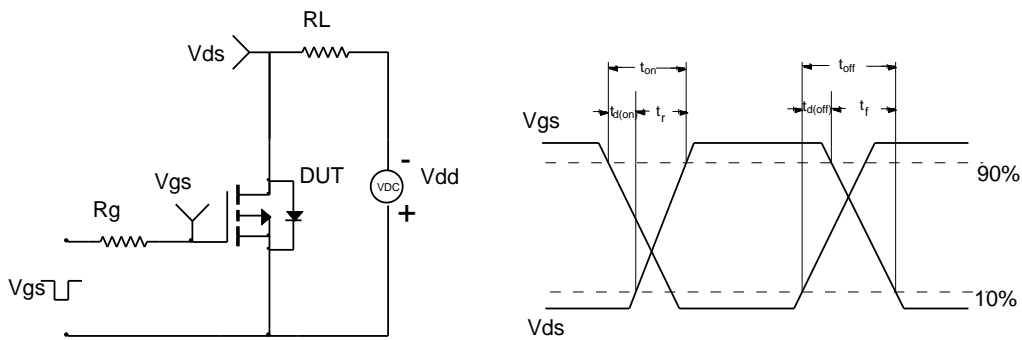


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

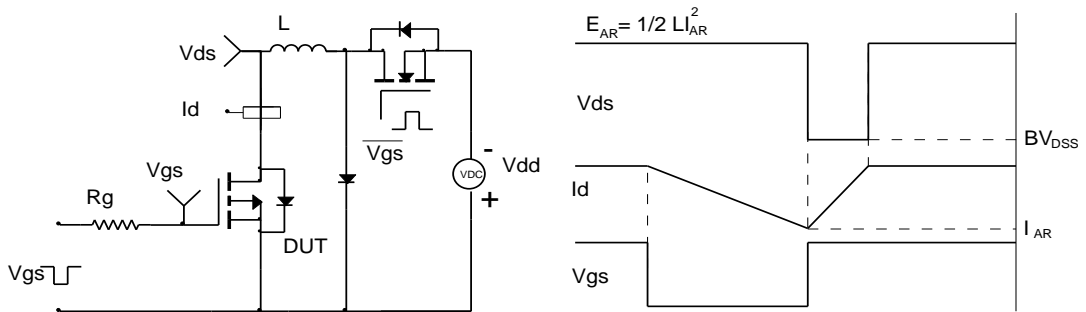
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

